Search Notes

_	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/796,132	MIZUTANI, AKIHIRO
	Examiner	Art Unit
	Benjamin E. Lanier	2132

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Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Limited Search of 713/182-186 726/16-20 See Attachment	4/19/2007	B
East Search See Attachment	4/19/2007	be
Inventor Name Search Palm	4/19/2007	a